

**Search Notes**

Application/Control No.

10/564,890

Examiner

James Mackey

Applicant(s)/Patent under  
Reexamination

OGAWA, YUICHIRO

Art Unit

1722

**SEARCHED**

Class	Subclass	Date	Examiner
425	54, 55, 56, 57	6/11/2007	JPM
156	110.1	6/11/2007	JPM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Conducted INVENTOR name search in IFW	6/11/2007	JPM